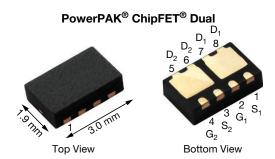




Dual N-Channel 30 V (D-S) MOSFET



PRODUCT SUMMARY					
V _{DS} (V)	R _{DS(on)} (Ω) MAX.	I _D (A)	Q _g (TYP.)		
	0.0192 at V _{GS} = 10 V	6 ^a			
30	0.0220 at V _{GS} = 6 V	6 ^a	4.7 nC		
	0.0245 at V _{GS} = 4.5 V	6 ^a			

Marking Code: CG
Ordering Information:

Si5922DU-T1-GE3 (lead (Pb)-free and halogen-free)

FEATURES

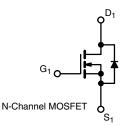
- TrenchFET® power MOSFET
- 100 % R_q and UIS tested
- New thermally enhanced PowerPAK® ChipFET® package
 - Small footprint area
 - Low on-resistance
 - Thin 0.8 mm profile
- Material categorization: for definitions of compliance please see <u>www.vishay.com/doc?99912</u>

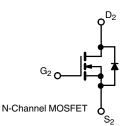


ROHS COMPLIANT HALOGEN FREE

APPLICATIONS

DC/DC power supply





PARAMETER		SYMBOL	LIMIT	UNIT	
Drain-Source Voltage	V _{DS}	30	V		
Gate-Source Voltage	V _{GS}	+20 / -16	v		
	T _C = 25 °C		6 ^a		
Continues Durin Comment (T. 150 °C)	T _C = 70 °C		6 ^a		
Continuous Drain Current (T _J = 150 °C)	T _A = 25 °C	I _D	6 ^{a, b, c}		
	T _A = 70 °C		6 a, b, c	_	
Pulsed Drain Current (t = 100 μs)		I _{DM}	24	A	
Continuous Common Busin Binds Commont	T _C = 25 °C		6 ^a		
Continuous Source-Drain Diode Current	T _A = 25 °C	I _S	1.9 ^{b, c}		
Single Pulse Avalanche Current	l 0.1 mall	I _{AS}	10		
Avalanche Energy L = 0.1 mH		E _{AS}	5	mJ	
	T _C = 25 °C		10.4		
Mayimum Dawar Dissination	T _C = 70 °C		6.7	W	
Maximum Power Dissipation	T _A = 25 °C	P _D	2.3 b, c		
	T _A = 70 °C		1.5 ^{b, c}		
Operating Junction and Storage Temperature R	T _J , T _{stg}	-55 to +150	00		
Soldering Recommendations (Peak Temperatur		260	°C		

THERMAL RESISTANCE RATINGS						
PARAMETER		SYMBOL	TYPICAL	MAXIMUM	UNIT	
Maximum Junction-to-Ambient b, f	t ≤ 5 s	R_{thJA}	43	55	°C/W	
Maximum Junction-to-Case (Drain)	Steady State	R_{thJC}	9.5	12	C/VV	

Notes

- a. Package limited.
- b. Surface mounted on 1" x 1" FR4 board.
- c. t = 5 s
- d. See solder profile (www.vishay.com/ppg?73257). The PowerPAK ChipFET is a leadless package. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection.
- e. Rework conditions: manual soldering with a soldering iron is not recommended for leadless components.
- f. Maximum under steady state conditions is 105 °C/W.

Vishay Siliconix

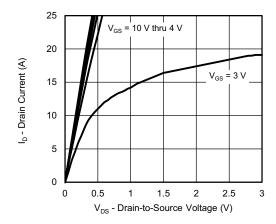
SPECIFICATIONS (T _J = 25 °C, unless otherwise noted)							
PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT	
Static				•			
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	30	-	-	V	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$ $\Delta V_{GS(th)}/T_{J}$	J 050 A	-	14.3	-	mV/°C	
V _{GS(th)} Temperature Coefficient		I _D = 250 μA	-	-4.7	-		
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_D = 250 \mu A$	1.2	-	2.2	V	
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = +20 \text{ V} / -16 \text{ V}$	-	-	± 100	nA	
Zoro Coto Voltago Desig Coment	I _{DSS}	$V_{DS} = 30 \text{ V}, V_{GS} = 0 \text{ V}$	=	-	1	μА	
Zero Gate Voltage Drain Current		$V_{DS} = 30 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 55 ^{\circ}\text{C}$	=.	-	10		
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \ge 5 \text{ V}, V_{GS} = 10 \text{ V}$	5	-	-	Α	
		V _{GS} = 10 V, I _D = 5 A	=.	0.0155	0.0192		
Drain-Source On-State Resistance ^a	R _{DS(on)}	V _{GS} = 6 V, I _D = 4 A	=	0.0170	0.0220	Ω	
		V _{GS} = 4.5 V, I _D = 4 A	=	0.0190	0.0245		
Forward Transconductance a	9 _{fs}	V _{DS} = 10 V, I _D = 5 A	=	22	-	S	
Dynamic ^b							
Input Capacitance	C _{iss}	viss		765	-		
Output Capacitance	C _{oss}	$V_{DS} = 15 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$	-	225	-	pF	
Reverse Transfer Capacitance	C _{rss}		-	14	-		
C _{rss} /C _{iss} Ratio			-	0.018	0.036	-	
Tatal Oata Ohausa	0	V _{DS} = 15 V, V _{GS} = 10 V, I _D = 5 A	-	10	15	nC	
Total Gate Charge	Q _g		-	4.7	7.1		
Gate-Source Charge		$V_{DS} = 15 \text{ V}, V_{GS} = 4.5 \text{ V}, I_D = 5 \text{ A}$	=.	2.2	-		
Gate-Drain Charge	Q_{gd}		-	0.65	-		
Output Charge	Q _{oss}	V _{DS} = 15 V, V _{GS} = 0 V	=	6.5	-		
Gate Resistance	R_g	f = 1 MHz	1.3	6.3	12.6	Ω	
Turn-On Delay Time	t _{d(on)}		=.	6	15		
Rise Time	t _r	$V_{DD} = 15 \text{ V}, R_L = 3 \Omega$		25	50		
Turn-Off Delay Time	t _{d(off)}	$I_D \cong 5 \text{ A}, V_{GEN} = 10 \text{ V}, R_g = 1 \Omega$	-	15	30		
Fall Time	t _f		-	10	20		
Turn-On Delay Time	t _{d(on)}		=	17	35	ns	
Rise Time	t _r	$V_{DD} = 15 \text{ V}, R_L = 3 \Omega$	-	45	90	-	
Turn-Off Delay Time	t _{d(off)}	$I_D \cong 5$ A, $V_{GEN} = 4.5$ V, $R_g = 1$ Ω	-	16	30		
Fall Time	t _f		-	27	50		
Drain-Source Body Diode Characteristic	cs						
Continuous Source-Drain Diode Current	Is	T _C = 25 °C	=.	-	6	^	
Pulse Diode Forward Current (t = 100 μs)	I _{SM}		-	-	24	A	
Body Diode Voltage	V_{SD}	I _S = 5 A, V _{GS} = 0 V	-	0.81	1.2	V	
Body Diode Reverse Recovery Time	t _{rr}		-	21	40	ns	
Body Diode Reverse Recovery Charge	Q _{rr}	L EA dl/dt 100 A/vo T 05 °C	-	10	20	nC	
Reverse Recovery Fall Time	ta	$I_F = 5 \text{ A}, \text{ dI/dt} = 100 \text{ A/}\mu\text{s}, T_J = 25 ^{\circ}\text{C}$	-	12	-	ns	
Reverse Recovery Rise Time	t _b		-	9	-		

Notes

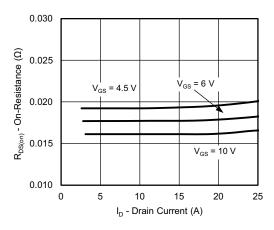
- a. Pulse test; pulse width $\leq 300~\mu s,$ duty cycle $\leq 2~\%.$
- b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

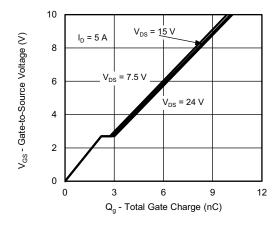




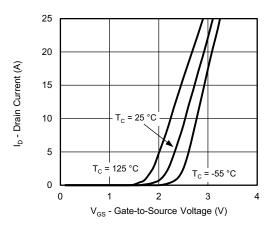
Output Characteristics



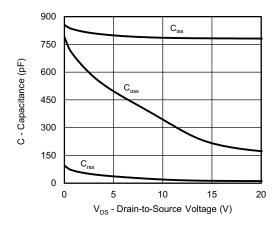
On-Resistance vs. Drain Current and Gate Voltage



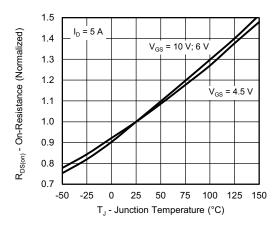
Gate Charge



Transfer Characteristics

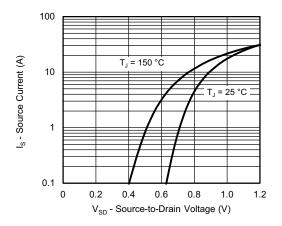


Capacitance

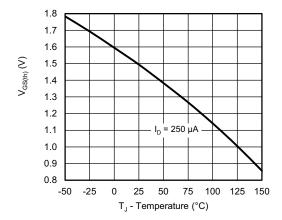


On-Resistance vs. Junction Temperature

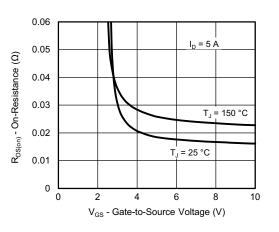




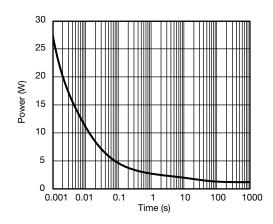
Source-Drain Diode Forward Voltage



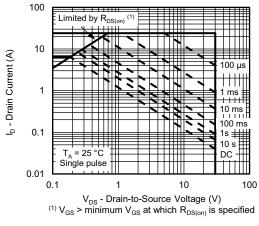
Threshold Voltage



On-Resistance vs. Gate-to-Source Voltage

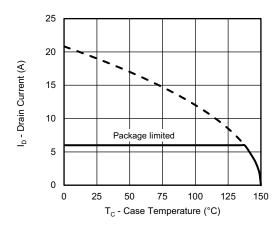


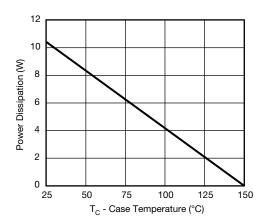
Single Pulse Power, Junction-to-Ambient



Safe Operating Area





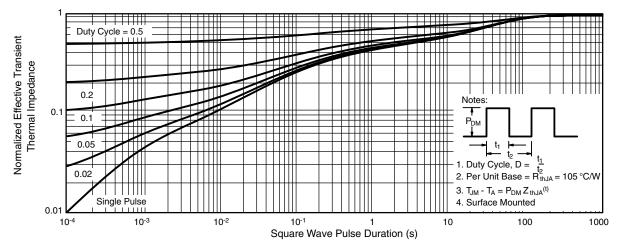


Current Derating a

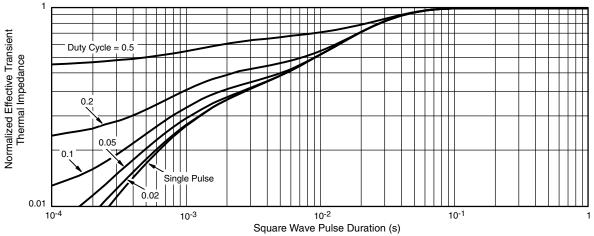
Power Derating

a. The power dissipation P_D is based on T_J (max.) = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the





Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Case

Vishay Siliconix maintains worldwide manufacturing capability. Products may be manufactured at one of several qualified locations. Reliability data for Silicon Technology and Package Reliability represent a composite of all qualified locations. For related documents such as package/tape drawings, part marking, and reliability data, see www.vishay.com/ppg?76056.



Legal Disclaimer Notice

Vishay

Disclaimer

ALL PRODUCT, PRODUCT SPECIFICATIONS AND DATA ARE SUBJECT TO CHANGE WITHOUT NOTICE TO IMPROVE RELIABILITY, FUNCTION OR DESIGN OR OTHERWISE.

Vishay Intertechnology, Inc., its affiliates, agents, and employees, and all persons acting on its or their behalf (collectively, "Vishay"), disclaim any and all liability for any errors, inaccuracies or incompleteness contained in any datasheet or in any other disclosure relating to any product.

Vishay makes no warranty, representation or guarantee regarding the suitability of the products for any particular purpose or the continuing production of any product. To the maximum extent permitted by applicable law, Vishay disclaims (i) any and all liability arising out of the application or use of any product, (ii) any and all liability, including without limitation special, consequential or incidental damages, and (iii) any and all implied warranties, including warranties of fitness for particular purpose, non-infringement and merchantability.

Statements regarding the suitability of products for certain types of applications are based on Vishay's knowledge of typical requirements that are often placed on Vishay products in generic applications. Such statements are not binding statements about the suitability of products for a particular application. It is the customer's responsibility to validate that a particular product with the properties described in the product specification is suitable for use in a particular application. Parameters provided in datasheets and / or specifications may vary in different applications and performance may vary over time. All operating parameters, including typical parameters, must be validated for each customer application by the customer's technical experts. Product specifications do not expand or otherwise modify Vishay's terms and conditions of purchase, including but not limited to the warranty expressed therein.

Except as expressly indicated in writing, Vishay products are not designed for use in medical, life-saving, or life-sustaining applications or for any other application in which the failure of the Vishay product could result in personal injury or death. Customers using or selling Vishay products not expressly indicated for use in such applications do so at their own risk. Please contact authorized Vishay personnel to obtain written terms and conditions regarding products designed for such applications.

No license, express or implied, by estoppel or otherwise, to any intellectual property rights is granted by this document or by any conduct of Vishay. Product names and markings noted herein may be trademarks of their respective owners.

Revision: 13-Jun-16 1 Document Number: 91000